Search Notes						

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Applicant(s)	
CHEN ET AL.	
Art Unit	
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M. Alexandra Elve

SEARCHED			
Class	Subclass	Date	Examiner
219	146.310	3/4/2003	MAE
219	146.1	3/4/2003	MAE
219	145.1	3/4/2003	MAE
219	146.41	3/4/2003	MAE
219	146.51	3/4/2003	MAE
update	same	9/30/2003	MAE
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH		·)
	DATE	EXMR
US PAT, US PG, Derwent, JPO, EPO	3/4/2003	MAE
Inventor search in PALM (double patenting)	3/7/2003	MAE